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ISL70591SEH, ISL70592SEH, ISL73591SEH, ISL73592SEH

Radiation Hardened 100µA and 1mA Precision Current Sources

FN9335 Rev.0.00 Aug 30, 2018

DATASHEET

The ISL70591SEH, ISL73591SEH, ISL70592SEH, and

<u>ISL73592SEH</u> are radiation hardened precision $100\mu A$ and 1mA current source ICs. The devices have excellent accuracy of $\pm 1\%$ over a wide operating voltage range of 3V to 40V and over a temperature range of -55°C to +125°C. Fabricated with the Renesas proprietary PR40 Silicon On Insulator (SOI) process, the devices are immune to single event latch-up.

The high output impedance of the devices make them insensitive to the voltage drops across long lines. They can withstand a forward operating voltage of 40V and a reverse voltage of -0.5V.

The ISL7x591SEH and ISL7x592SEH are two terminal floating current sources and that allows them to be used in high side, low side, and dual side load applications such as sensor excitation, biasing networks, low voltage references, floating voltage references, and ramp generators. The current sources were primarily designed for thermistor and other sensor excitation applications widely used in space crafts.

The ISL7x591SEH and ISL7x592SEH are available in a 4 Ld ceramic flatpack and die forms. The temperature range is -55°C to +125°C.

Applications

- Sensor excitation
- Biasing network
- Low voltage references
- Ramp generators

Features

- Electrically screened to DLA SMD <u>5962-18217</u>
- Wide operating voltage range: 3V to 40V
- High initial accuracy ($+V = 20V \text{ at } +25^{\circ}\text{C}$):
 - ISL7x591SEH: ±0.34%
 - ISL7x592SEH: ±0.30%
- High output impedance:
 - ISL7x591SEH: 189MΩ (typical)
 - ISL7x592SEH: 14MΩ (typical)
- Completely floating: No ground connection
- Radiation acceptance testing ISL70591SEH and ISL70592SEH
 - High dose rate (50-300rad(Si)/s): 100krad(Si)
 - Low dose rate (0.01rad(Si)/s): 75krad(Si)
- Radiation acceptance testing ISL73591SEH and ISL73592SEH
 - Low dose rate (0.01rad(Si)/s): 75krad(Si)
- SEE hardness
 - No SEB/SEL LET_{TH.} +V = 35V: $86 MeV \cdot cm^2/mg$
 - SET duration (time recovery) $\leq 125 \mu s$

Related Literature

For a full list of related documents, visit our website:

• <u>ISL70591SEH</u>, <u>ISL70592SEH</u>, <u>ISL73591SEH</u>, and <u>ISL73592SEH</u> product pages.











Figure 3. Output Current vs +V Voltage vs Temperature for the ISL7X592SEH

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1. Overview

1.1 Block Diagram



Figure 4. Block Diagram

1.2 Ordering Information

Ordering / SMD Number (<u>Note 1</u>)	Part Number (<u>Note 2</u>)	Temperature Range (°C)	Package (RoHS Compliant)	Package Drawing
5962R1821701VXC	ISL70591SEHVF	-55 to +125	4 Ld Ceramic Flatpack	K4.A
5962R1821701V9A	ISL70591SEHVX	-55 to +125	Die	
5962L1821702VXC	ISL73591SEHVF	-55 to +125	4 Ld Ceramic Flatpack	K4.A
5962L1821702V9A	ISL73591SEHVX	-55 to +125	Die	
N/A	ISL73591SEHF/PROTO, (<u>Note 3</u>)	-55 to +125	4 Ld Ceramic Flatpack	K4.A
N/A	ISL70591SEHF/PROTO, (<u>Note 3</u>)	-55 to +125	4 Ld Ceramic Flatpack	K4.A
N/A	ISL70591SEHX/SAMPLE, (<u>Note 3</u>)	+25	Die	
5962R1821703VXC	ISL70592SEHVF	-55 to +125	4 Ld Ceramic Flatpack	K4.A
5962R1821703V9A	ISL70592SEHVX	-55 to +125	Die	
5962L1821704VXC	ISL73592SEHVF	-55 to +125	4 Ld Ceramic Flatpack	K4.A
5962L1821704V9A	ISL73592SEHVX	-55 to +125	Die	
N/A	ISL70592SEHF/PROTO, (<u>Note 3</u>)	-55 to +125	4 Ld Ceramic Flatpack	K4.A
N/A	ISL70592SEHX/SAMPLE, (<u>Note 3</u>)	+25	Die	
N/A	ISL73592SEHF/PROTO, (<u>Note 3</u>)	-55 to +125	4 Ld Ceramic Flatpack	K4.A
N/A	ISL70591SEHEVAL1Z, (<u>Note 4</u>)	Evaluation Board	÷	•
N/A	ISL70592SEHEVAL1Z, (<u>Note 4</u>)	Evaluation Board		

Notes:

1. Specifications for Rad Hard QML devices are controlled by the Defense Logistics Agency Land and Maritime (DLA). The SMD numbers must be used when ordering.

2. These Pb-free Hermetic packaged products employ 100% Au plate - e4 termination finish, which is RoHS compliant and compatible with both SnPb and Pb-free soldering operations.

3. The /PROTO and /SAMPLE are not rated or certified for Total Ionizing Dose (TID) or Single Event Effect (SEE) immunity. These parts are intended for engineering evaluation purposes only. The /PROTO parts meet the electrical limits and conditions over-temperature specified in the DLA SMD and are in the same form and fit as the qualified device. The /SAMPLE parts are capable of meeting the electrical limits and conditions specified in the DLA SMD at +25°C only. The /SAMPLE parts do not receive 100% screening over-temperature to the DLA SMD electrical limits. These part types do not come with a Certificate of Conformance because they may not have been Radiation Assurance tested and they are not DLA qualified devices.

4. Evaluation boards use the /PROTO parts and /PROTO parts are not rated or certified for Total Ionizing Dose (TID) or Single Event Effect (SEE) immunity.



Specification	ISL70591SEH	ISL73591SEH	ISL70592SEH	ISL73592SEH		
Output Current	100µA	100µA	1mA	1mA		
Current Temperature Coefficient	2.25nA/°C	2.25nA/°C	19nA/°C	19nA/°C		
Output Impedance	189MΩ	189MΩ	14ΜΩ	14ΜΩ		
HDR 100krad(Si)	Yes	N/A	Yes	N/A		
LDR 75krad(Si)	Yes	Yes	Yes	Yes		

Table 1. ISL7x59xSEH Product Family Feature Table

N/A: Not Applicable

1.3 Pin Configurations



Note: The ESD triangular mark is indicative of Pin 1. It is a part of the device marking and is placed on the lid in the quadrant where Pin 1 is located.

1.4 Pin Descriptions

Pin Number	Pin Name	ESD Circuit	Description
1	+V	1	Positive voltage lead, range 3V to 40V with respect to -V.
2	DNC		DNC (Do Not Connect) = OPEN (Float). Internally connected.
3	DNC		DNC (Do Not Connect) = OPEN (Float). Internally connected.
4	-V		Negative voltage lead.
-	Package Lid	-	Internally connected to -V (Pin 4).



Figure 5. ESD Circuit 1

1.5 Typical Application Schematics



Figure 6. Sensor Signal Conditioning and Data Acquisition Application

2. Specifications

2.1 Absolute Maximum Ratings

Parameter	Minimum	Maximum	Unit
Maximum Supply Voltage	+42		V
In-Beam Maximum Supply Voltage (Note 5)		+35	V
Maximum Reverse Voltage		-0.5	V
ESD Rating	Value		Unit
Human Body Model (Tested per MIL-STD-883 TM3015.7)	7		kV
Charged Device Model (Tested per JS-002-2014)	75	50	V

Note:

5. The maximum supply voltage specified is for operation in a heavy ion environment at an LET = 86.4 MeV•cm²/mg and +125°C case temperature. Refer to single event effects test report for more information.

CAUTION: Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions may adversely impact product reliability and result in failures not covered by warranty.

2.2 Thermal Information

Thermal Resistance (Typical)	θ _{JA} (°C/W)	θ _{JC} (°C/W)
4 Ld CFP Package (<u>Notes 6, 8</u>)	173	11
4 Ld CFP Package (<u>Notes 7</u> , <u>8</u>)	53	11

Notes:

θ_{JA} is measured with the component mounted on a high-effective thermal conductivity test board (2 buried 1oz planes). Air GAP between Pkg and PCB. See <u>TB379</u>.

 θ_{JA} is measured with the component mounted on a high-effective thermal conductivity test board with direct attach features (2 buried 1oz planes, thermal land under pkg with 16 vias touching 1 of the buried planes). Pkg base mounted to PCB thermal land with 0.25mm (~ 10mil) thick adhesive material with "k" of 1 W/m-K.

8. For θ_{JC} , the "case temp" location is the center of the package underside.

Parameter	Minimum	Maximum	Unit
Maximum Junction Temperature		+150	°C
Storage Temperature Range	-65	+150	°C

2.3 Recommended Operating Conditions

Parameter	Minimum	Maximum	Unit
Ambient Temperature	-55	+125	°C
Supply Voltage	3	40	V
Supply Voltage under Ion Beam	3	35	V

2.4 Electrical Specifications

Recommended operating conditions, +V = 20V, T_A = +25° unless otherwise specified.

Parameter	Symbol	Test Conditions	Temperature	Min (<u>Note 10</u>)	Typ (<u>Note 9</u>)	Max (<u>Note 10</u>)	Unit
ISL70591SEH, ISL73059	1SEH (100	µA) Current Source Specificatio	ns	1	1		
Input Voltage Range	+V		-55°C to +125°C	3	-	40	V
Output Current at 40V	IO _{40V}	+V = 40V	-55°C	99.39	100.08	100.78	μA
			+25°C	99.79	100.24	100.69	
			+125°C	99.33	99.90	100.47	
		+V = 40V, Post Rad	+25°C - Post Rad	99.44	100.13	100.80	
Output Current at 30V	IO _{30V}	+V = 30V	-55°C	99.22	99.78	100.34	μA
			+25°C	99.75	100.09	100.43	
			+125°C	99.39	99.80	100.23	
		+V = 30V, Post Rad	+25°C - Post Rad	99.29	99.90	100.57	
Output Current at 20V	IO _{20V}	+V = 20V	-55°C	99.12	99.67	100.23	μA
			+25°C	99.71	100.05	100.38	
			+125°C	99.39	99.76	100.16	
		+V = 20V, Post Rad	+25°C - Post Rad	99.23	99.86	100.53	
Output Current at 12V	IO _{12V}	+V = 12V	-55°C	99.04	99.61	100.18	μA
			+25°C	99.67	100.03	100.38	
			+125°C	99.35	99.73	100.15	
		+V = 12V, Post Rad	+25°C - Post Rad	99.16	99.83	100.54	
Output Current at 3V	IO _{3V}	+V = 3V	-55°C	98.88	99.50	100.12	μA
			+25°C	99.58	100.00	100.42	
			+125°C	99.26	99.75	100.26	
		+V = 3V, Post Rad	+25°C - Post Rad	99.03	99.80	100.58	
Output Current Temperature Coefficient	I _{OTC}	<u>Note 11</u>	-55°C to +125°C	-	2.25	-	nA/°C
Output Impedance	R _{OUT}	+V = 3V to 40V, Five Point Box	-55°C to +125°C	40	189	-	MΩ
		Method, Points: 3V, 12V, 20V, 30V, and 40V. Inverse of (Imax - Imin) / Voltage Range.	+25°C - Post Rad	40	189	-	
Noise Current Density	i _n	f = 100Hz	+25°C	-	57	-	pA/√Hz
Effective Shunt Capacitance	C _S	$f = 1MHz$, $V_{BIAS} = 20V$, LCR meter across the current source pins to measure the capacitance.	+25°C	-	24	-	pF

Parameter	Symbol	Test Conditions	Temperature	Min (<u>Note 10</u>)	Typ (<u>Note 9</u>)	Max (<u>Note 10</u>)	Unit
Turn-On Time	t _{ON}	+V = 0V to 3.1V with a	-55°C to +125°C	-	117	260	μs
		3.1V/10 μ s ramp, R _L = 1k Ω , Measure from 10% of +V to when V _{OUT} has settled to within 0.5% of V _{OUT} final value of 100mV. See Figure 7 and 8.	+25°C - Post Rad	-	117	260	
		+V = 0V to 40V with a	-55°C to +125°C	-	100	190	
		40V/100 μ s ramp, R _L = 1k Ω , Measure from 10% of +V to when V _{OUT} has settled to within 0.5% of V _{OUT} final value 100mV. See <u>Figure 7</u> and <u>8</u> .	+25°C - Post Rad	-	100	190	

Decomposed and an exciting a condition	11/-201/T = 107	· · · · · · · · · · · · · · · · · · ·	aified (Continued)
Recommended operating conditions	, +v = 20v, 1 _A = +23	uniess otherwise spe	cillea. (Continuea)

Recommended operating conditions, +V = 20V, T_{A} = +25° unless otherwise specified.

Parameter	Symbol	Test Conditions	Temperature	Min (<u>Note 10</u>)	Typ (<u>Note 9</u>)	Max (<u>Note 10</u>)	Unit
ISL70592SEH, ISL73592	2SEH (1mA) Current Source Specificatio	ons			11	
Input Voltage Range	+V		-55°C to +125°C	3	-	40	V
Output Current at 40V	IO _{40V}	+V = 40V	-55°C	0.9957	1.0028	1.0100	mA
			+25°C	0.9994	1.0039	1.0078	
			+125°C	0.9944	1.0005	1.0066	
		+V = 40V, Post Rad	+25°C - Post Rad	0.9990	1.0051	1.0110	
Output Current at 30V	IO _{30V}	+V = 30V	-55°C	0.9933	0.9992	1.0051	mA
			+25°C	0.9986	1.0019	1.0052	
			+125°C	0.9945	0.9988	1.0031	
		+V = 30V, Post Rad	+25°C - Post Rad	0.9950	1.0020	1.0080	
Output Current at 20V	IO _{20V}	+V = 20V	-55°C	0.9919	0.9979	1.0038	mA
			+25°C	0.9980	1.0010	1.0040	
			+125°C	0.9940	0.9978	1.0019	
		+V = 20V, Post Rad	+25°C - Post Rad	0.9940	1.000	1.0070	
Output Current at 12V	IO _{12V}	+V = 12V	-55°C	0.9910	0.9971	1.0032	mA
			+25°C	0.9972	1.0004	1.0036	
			+125°C	0.9929	0.9970	1.0012	
		+V = 12V, Post Rad	+25°C - Post Rad	0.9930	0.9997	1.0070	
Output Current	IO _{3V}	+V = 3V	-55°C	0.9897	0.9962	1.0027	mA
			+25°C	0.9960	0.9999	1.0039	
			+125°C	0.9914	0.9965	1.0016	
		+V = 3V, Post Rad	+25°C - Post Rad	0.9910	0.9989	1.0070	
Output Current Temperature Coefficient	Іотс	Note 11	-55°C to +125°C	-	19	-	nA/°C

Parameter	Symbol	Test Conditions	Temperature	Min (<u>Note 10</u>)	Typ (<u>Note 9</u>)	Max (<u>Note 10</u>)	Unit
Output Impedance	R _{OUT}	+V = 3V to 40V, Five Point Box Method, Points: 3V, 12V, 20V, 30V, and 40V. Inverse of (Imax - Imin) / Voltage Range	-55°C to +125°C	4	14	-	MΩ
			+25°C - Post Rad	4	14	-	
Noise Current Density	i _n	f = 100Hz	+25°C	-	724	-	pA/√Hz
Effective Shunt Capacitance	C _S	$f = 1MHz$, $V_{BIAS} = 20$, LCR meter across the current source pins to measure the capacitance	+25°C	-	13	-	pF
Turn-On Time	t _{on}	+V = 0V to 4V with a 4V/10 μ s ramp, RL = 1k Ω , Measure from 10% of +V to when V _{OUT} has settled to within 0.5% of V _{OUT} final value of 1V. See <u>Figure 7</u> and <u>8</u> .	-55°C to +125°C	-	111	230	μs
			+25°C - Post Rad	-	111	230	
		+V = 0V to 40V with a 40V/100 μ s ramp, RL = 1k Ω , Measure from 10% of +V to when V _{OUT} has settled to within 0.5% of V _{OUT} final value 1V. See <u>Figure 7</u> and <u>8</u> .	-55°C to +125°C	-	80	170	
			+25°C - Post Rad	-	80	170	

Recommended operating conditions, +V = 20V, T_A = +25° unless otherwise specified. (Continued)

Notes:

9. Typical values shown are not guaranteed.

10. Parameters with MIN and/or MAX limits are 100% tested at -55°C, +25°C and +125°C, unless otherwise specified.

11. Over the specified temperature range. Temperature coefficient is measured by the box method whereby the change in I_{OUT} is divided by the temperature range; in this case, --55°C to +125°C = +180°. See "Application Information" section titled "Temperature Coefficient" for description of box method. T_C (nA/°C) = (I_{OUT} (max) - I_{OUT} (min)) / (T_{HIGH} - T_{LOW}). T_C (ppm/C) = [(I_{OUT} (max) - I_{OUT} (min)) / (T_{HIGH} - T_{LOW}) / Nominal I_{OUT} Current at 25°C]}x 10⁶.

2.5 Test Circuits and Waveforms



Note: 0V to 40V Ramp Rate 40V/100 μ s unless otherwise specified.

Figure 7. Electrical Turn-On Time Test Circuit



Note: Measure from 10% of V_S to when V_{OUT} has settled to within 0.5% of V_{OUT} final value.

Figure 8. Electrical Turn-On Time Wave Form

3. Typical Performance Curves

ISL7x591SEH 100 μ A: Unless otherwise noted, +V = 20V; -V - 0V; T_A = +25°C



Figure 9. Output Current vs Voltage vs Temperature



Figure 11. Output Current vs Temperature vs (12 units - 3 lots)



Figure 13. Current Temperature Coefficient vs Voltage



Figure 10. Output Current vs Temperature vs Voltage



100.006μA - 99.602μA/180°C = 0.404μA/180°C = 2.25nA/°C [2.25nA/°C/100uA] x 10⁶ = 22.5ppm/°C.

Figure 12. Typical Temperature Coefficient at +V = 20V







ISL7x591SEH 100 μ A: Unless otherwise noted, +V = 20V; -V - 0V; T_A = +25°C (Continued)











ISL7x591SEH 100 μ A: Unless otherwise noted, +V = 20V; -V - 0V; T_A = +25°C (Continued)

Figure 19. Noise Current Density



ISL7x592SEH 1mA: Unless otherwise noted, +V = 20V; -V - 0V; T_A = +25°C





Figure 22. Output Current vs Temperature vs (12 units -3 lots)



Figure 21. Output Current vs Temperature vs Voltage



1.00043mA - 0.99688mA/180°C = 0.00355mA/180°C = 19.7nA/°C [19.7nA/°C/1mA] x 10⁶ = 19.7ppm/°C

Figure 23. Temperature Coefficient at +V = 20V



Figure 24. Output Current Temperature Coefficient vs Voltage







ISL7x592SEH 1mA: Unless otherwise noted, +V = 20V; -V - 0V; T_A = +25°C (Continued)







Figure 29. Turn on Time Plot (4V/10µs Ramp)



ISL7x592SEH 1mA: Unless otherwise noted, +V = 20V; -V - 0V; T_A = +25°C (Continued)



4. Applications Information

4.1 Functional Description

The ISL7x591SEH and ISL7x592SEH are radiation hardened, precision constant current source ICs. The ISL70591SEH and ISL73591SEH are 100 μ A current sources and the ISL70592SEH and ISL73592SEH are 1mA current sources. The devices use a bandgap, servo amplifier, and special resistance trimming circuitry architecture to produce with ±1% accuracy a current source across both a wide compliance voltage range of 3V to 40V and a temperature range of -55°C to +125°C.

The two terminal floating type current sources can be used for high side load, low side load, or dual side load applications such as sensor excitation, biasing networks, low voltage references, floating voltage references, and ramp generators. The radiation hardened ICs are primarily designed for thermistor and other sensor excitation applications widely used in spacecrafts.

4.2 Temperature Coefficient

The typical value given for temperature coefficient (Tempco) is governed by the method of measurement. The overwhelming standard for specifying the temperature drift of a current source is to measure the current at two temperatures. Measuring the current at two temperatures provides for the maximum current deviation and takes the total variation, ($I_{HIGH} - I_{LOW}$). The total variation is divided by the temperature extremes of measurement ($T_{HIGH} - T_{LOW}$) to yield nA/°C. The result is divided by the nominal reference current (at T = +25°C) and multiplied by 10⁶ to yield ppm/°C, which is the "Box" method for specifying temperature coefficient. For the temperature coefficient of the ISL7x0591SEH see Figures 12 and 13, and for the ISL7x0592SEH, see Figures 23 and 24.

4.3 Floating Current Source Topology

The ISL7059xSEH and ISL73059xSEH devices are two terminal completely floating current sources. All the current entering the +V pin exits the -V pin. This allows for the circuit loading to be applied at the positive side (+V), or the negative side (-V), or at both the +V and -V sides of the current source.

The floating topology allows the current source to be used in a variety of applications that require loads to be connected as a "High Side Load", "Low Side Load", and "Dual Side Load."

4.3.1 High Side Load

Connect the current source to a negative power supply or ground on the negative voltage lead (-V). Connect the load between the positive voltage lead (+V) of the current source and to a positive power supply.

4.3.2 Low Side Load

Connect the current source directly to a positive power supply on the positive voltage lead (+V). Connect the load to the negative voltage lead (-V) and to either a negative power supply or to ground.

4.3.3 Dual Load Side

Connect the current source's first load to the positive voltage lead (+V) and a positive power supply. Connect the second load to the negative voltage lead (-V) and to either a negative power supply or to ground.

4.4 Power Supply Recommendations

The ISL7059xSEH and ISL73059xSEH devices have a wide compliance voltage range from 3V to 40V in terrestrial applications and 3V to 35V in space applications.

A minimum of at least 3V must be maintained across the current source for proper functionality. As the voltage across the current source drops below 3V, the current drops significantly and the part no longer operates as a current source.



4.5 Connecting Multiple Current Sources in Parallel for Higher Drive Current

The user can parallel multiple current sources together to build a current source with higher current capability. The current into the circuit load from paralleled current sources is equal to the summation of the current from each current source. For example, two ISL70592SEH current sources in parallel supplies 2mA of current to the circuit while three in parallel provides 3mA of current. A ISL70591SEH and ISL70592SEH in parallel provides 1.1mA to the load circuitry. The number of current sources you can connect in parallel is theoretically unlimited as long as the circuit loading maintains at least 3V across the +V and -V terminals of the ISL7059xSEH and ISL73059xSEH devices.

4.6 Circuit Considerations

- DNC Pins (Pin 2 and Pin 3): The pins are for trimming purpose and for factory use only. Do not connect these pins to the circuit in any way. It adversely effects the performance of the current source.
- A minimum of at least 3V must be maintained across the current source from +V to -V for proper functionality. As the voltage across the current source drops below 3V, the current out of the part drops off significantly and no longer functions as a current source.
- The maximum +V voltage compliance in a radiation environment should not exceed +35V. This family of current sources were tested under an ion beam at an LET of 86MeV•cm²/mg and did not latch-up or burn out to +V of 35V and +125°C. The maximum +V voltage in terrestrial environment should not exceed +40V.
- The current source has a reverse current ABS maximum rating of -0.5V. Use a protection circuitry such as a parallel Schottky diode across the current source to prevent the reverse voltage from exceeding -0.5V.

5. Die Characteristics

Die Information	
Dimensions	2413µm x 1397µm (95 mils x 55 mils)
	Thickness: 483µm ±25.4µm (19 mils ±1 mil)
Interface Materials	
Glassivation	Type: 15kA Nitrox
Top Metallization	Type: AlCu (99.5%/0.5%)
	Thickness: 30kA
Backside Finish	Silicon
Process	Dielectrically Isolated Advanced Bipolar Technology - PR40
Assembly Information	
Substrate Potential	Float
Additional Information	· · ·
Transistor Count	155
Weight of Packaged Device	0.24 Grams (typical) - K4.A Package
Lid Characteristics	Finish: Gold
	Potential: Tied to -V pin (Pin 4)

Table 2. Die and Assembly Related Information

6. Metallization Mask Layout



Table 3. Layout X-Y Coordinates

Pad Name	Pad Number	χ (μm)	Υ (μm)	dX (µm)	dY (µm)
+V	1	-1025.5	34.5	110.0	110.0
DNC	2	-	-	-	-
DNC	3	-	-	-	-
-V	4	1025.5	408.0	110.0	110.0

Note: Origin of the coordinates is the center of the die. Pads sorted in counter clock wise direction.

7. Revision History

Rev.	Date	Change
0.00	Aug 30, 2018	Initial Release

8. Package Outline Drawing

For the most recent package outline drawing, see K4.A.

K4.A

4 Lead Ceramic Metal Seal Flatpack Package (100 mil Lead Pitch) Rev 0, 3/17



8. Dimensions: INCH (mm), Controlling dimension: INCH.

0.006 (0.15)

0.004 (0.10)

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